


<b>Search Notes</b>  	<b>Application/Control No.</b>  10538549	<b>Applicant(s)/Patent Under Reexamination</b>  KANG ET AL.
	<b>Examiner</b>  Takele, Meseker	<b>Art Unit</b>  2174

SEARCHED			
Class	Subclass	Date	Examiner
715	816, 715, 711, 827, 864, 811	3/27/2008	MT
455	550.1	3/27/2008	MT
345	157, 161, 169	3/27/2008	MT

SEARCH NOTES		
Search Notes	Date	Examiner
East (US -PGPUB, USPAT, IBM_TDB, USOCR, FPRS, EPO, JPO, DERWENT)	3/27/2008	MT
Consult wit Primary Sy Luu	07/02/2007	MT
Consult with Lance Sealey (Search strategy expert)	06/28/2007	MT
Google and NPL search	3/27/2008	MT
Inventor search	3/27/2008	MT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner